Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination	_
l	10/068,160	KLINMAN ET AL.	
Ī	Examiner	Art Unit	_
	Dave T. Nguyen	1632	

	SEARCHED				
Class	Subclass	['] Date	Examiner		
536	23.1	5/11/2005	DTN		
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SEARCH NOT (INCLUDING SEARCH)
·	DATE	EXMR
Stic Chem searched, related cases reviewed (priority and claims): 09/874991; 10/194,035; 10/486755; 10/6666022; 10/499,597	5/11/2005	DTN